

<b>Notice of References Cited</b>	Application/Control No. 10/690,936		Applicant(s)/Patent Under Reexamination BADENELL, JON E.	
	Examiner Nnenna N. Ekpo		Art Unit 2425	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,654,886	08-1997	Zereski et al.	702/3
*	B	US-2002/0016963	02-2002	INOUE et al.	725/39
*	C	US-2004/0010372	01-2004	Schwoegler, Bruce	702/3
*	D	US-6,961,061	11-2005	Johnson et al.	345/473
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	S					
	T					

**NON-PATENT DOCUMENTS**

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